

# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value Q1	Value Q2	Units
Drain-Source Voltage			V <sub>DSS</sub>	30	-30	V
Gate-Source Voltage			V <sub>GSS</sub>	±20	±20	V
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	Steady	T <sub>A</sub> = +25°C	I <sub>D</sub>	8.2	-6.2	А
	State	$T_{A} = +70^{\circ}C$	U	6.5	-5.0	
	t<10s	T <sub>A</sub> = +25°C	ID	10.5	-8.0	А
		$T_{A} = +70^{\circ}C$		8.4	-6.4	
Maximum Body Diode Forward Current (Note 6)			I <sub>S</sub>	2.5	-2.5	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I <sub>DM</sub>	80	-40	А
Avalanche Current (Note 7) L = 0.1mH			I <sub>AS</sub>	22	-22	A
Avalanche Energy (Note 7) L = 0.1mH			E <sub>AS</sub>	25	25	mJ

#### **Thermal Characteristics**

Characteristic	Symbol	Value	Units	
Total Dawar Dissinction (Note 5)	T <sub>A</sub> = +25°C	D	1.2	W
Total Power Dissipation (Note 5)	T <sub>A</sub> = +70°C	PD	0.8	vv
Thermal Registeres Junction to Ambient (Note 5)	Steady State	D	102	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	62	
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	D	1.6	W
	T <sub>A</sub> = +70°C	PD	1.0	
Thermal Registeres, Junction to Ambient (Note 6)	Steady State	D	78	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	47	
Thermal Resistance, Junction to Case (Note 6)	R <sub>0JC</sub>	12		
Operating and Storage Temperature Range		TJ, TSTG	-55 to +150	°C

#### Electrical Characteristics (N-Channel Q1) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)	1 -				•	-
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current	IDSS	_	_	1	μA	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	—	3.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	Passau	_	12	16	mΩ	$V_{GS} = 10V, I_D = 12A$
	R <sub>DS(ON)</sub>	_	15	20	11152	$V_{GS} = 4.5V, I_D = 10A$
Diode Forward Voltage	V <sub>SD</sub>		0.7	1.0	V	$V_{GS} = 0V, I_S = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C <sub>ISS</sub>		1,415	—		V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V, f = 1.0MHz
Output Capacitance	C <sub>OSS</sub>		119	_	pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>		82			
Gate Resistance	R <sub>G</sub>		2.6	3.2	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge ( $V_{GS} = 4.5V$ )	$Q_G$	_	11.3	_		V <sub>DS</sub> = 15V, I <sub>D</sub> = 12A
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_G$	_	25.1	_	nC	
Gate-Source Charge	Q <sub>GS</sub>	_	3.5	_	nc	
Gate-Drain Charge	Q <sub>GD</sub>	_	3.6	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	4.8	_	ns	V <sub>DD</sub> = 15V, V <sub>GS</sub> = 10V,
Turn-On Rise Time	t <sub>R</sub>	_	16.5	_		
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	26.1		115	$R_L = 1.25\Omega, \ R_G = 3\Omega,$
Turn-Off Fall Time	t <sub>F</sub>		5.6			

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.

7. UIS in production with L = 0.1mH, starting  $T_A = +25^{\circ}C$ .

8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.

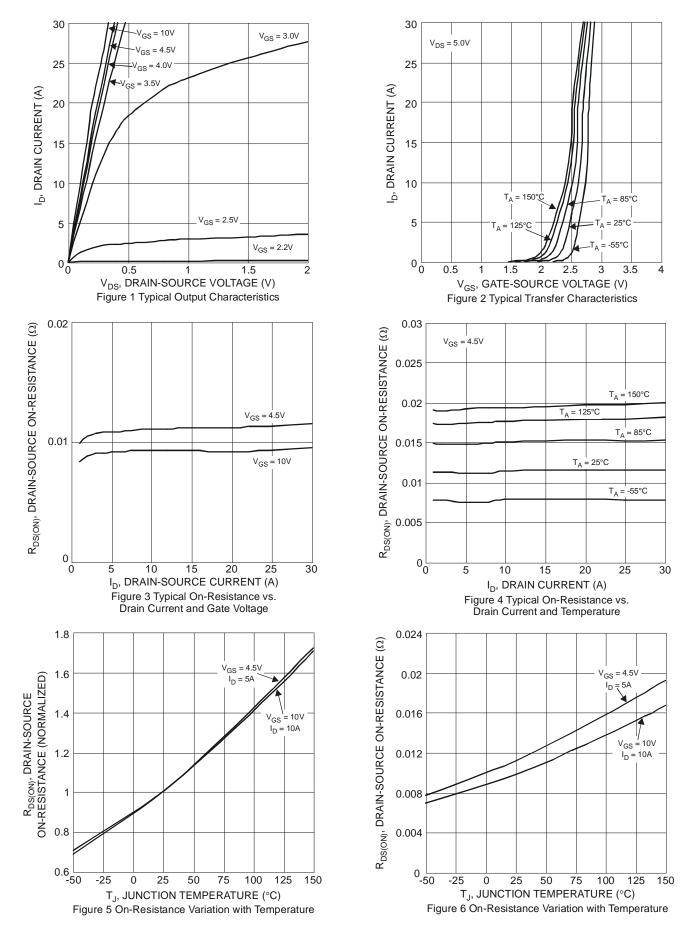


Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)	•		•			·	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	—		V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	IDSS		_	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)	•		•			·	
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1.0	—	-3.0	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$	
Static Drain-Source On-Resistance	Desser		21	28	mΩ	$V_{GS} = -10V, I_D = -7A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>		30	38		$V_{GS} = -4.5V, I_D = -6.2A$	
Diode Forward Voltage	V <sub>SD</sub>		-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -2.1A$	
DYNAMIC CHARACTERISTICS (Note 9)	•		•			·	
Input Capacitance	CISS	_	1,241		pF	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V f = 1.0MHz	
Output Capacitance	C <sub>OSS</sub>		147				
Reverse Transfer Capacitance	C <sub>RSS</sub>		110				
Gate Resistance	R <sub>G</sub>		15		Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Q <sub>G</sub>	_	10.9			Vds = -15V, Id = -7A	
Total Gate Charge (V <sub>GS</sub> = -10V)	Q <sub>G</sub>		22				
Gate-Source Charge	Q <sub>GS</sub>		3.5		nC		
Gate-Drain Charge	Q <sub>GD</sub>		4.7				
Turn-On Delay Time	t <sub>D(ON)</sub>		9.7	_		Vbs = -15V, lb = -7A Vgs = -10V, Rg =6Ω	
Turn-On Rise Time	t <sub>R</sub>	—	17.1	_			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	—	60.5	_	ns		

#### Electrical Characteristics (Continued) (P-Channel Q2) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

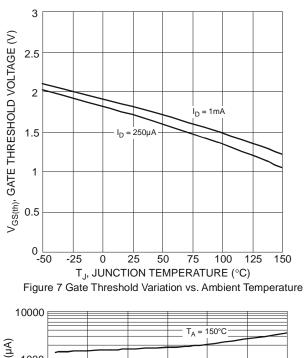


### DMC3016LSD



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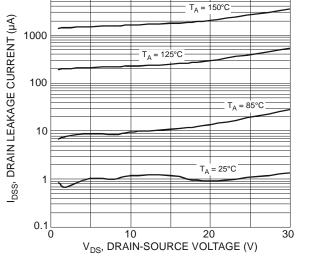
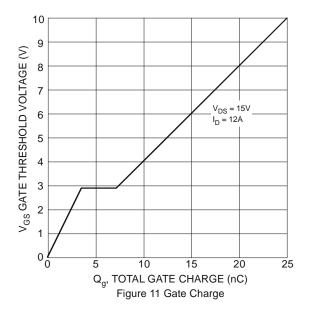


Figure 9 Typical Drain-Source Leakage Current vs. Voltage



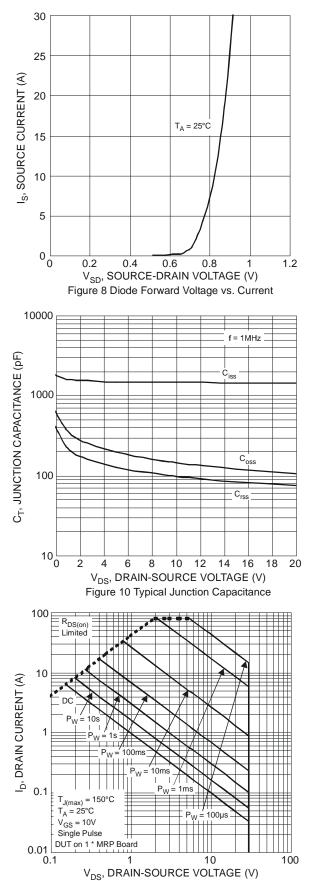


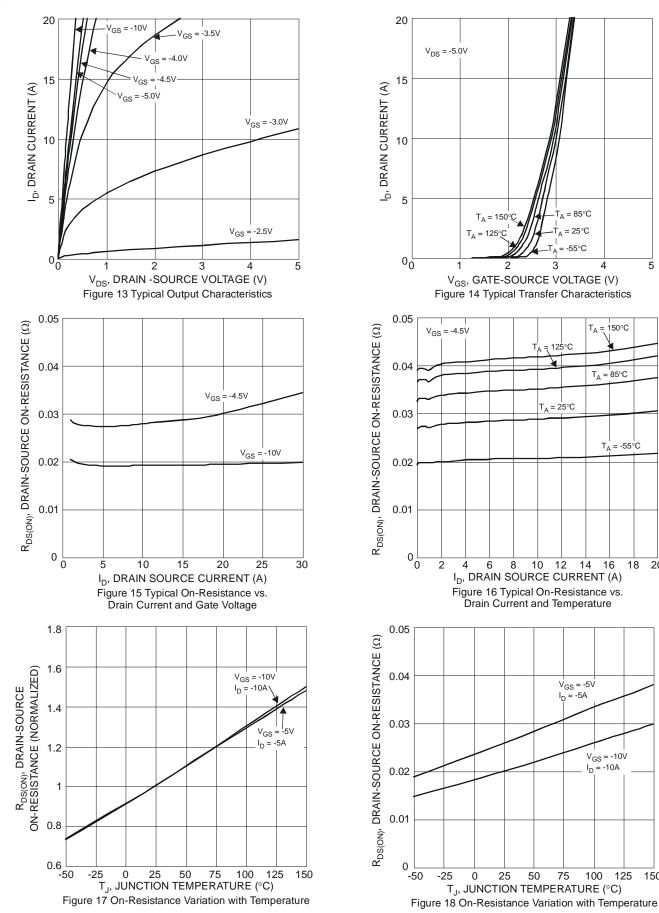
Figure 12 SOA, Safe Operation Area



### DMC3016LSD

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18 20



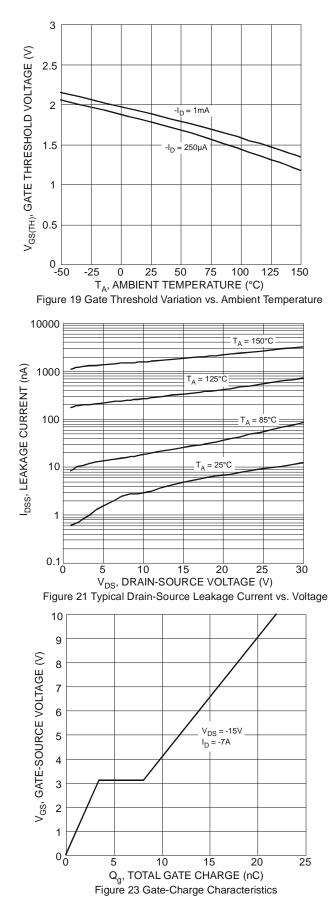
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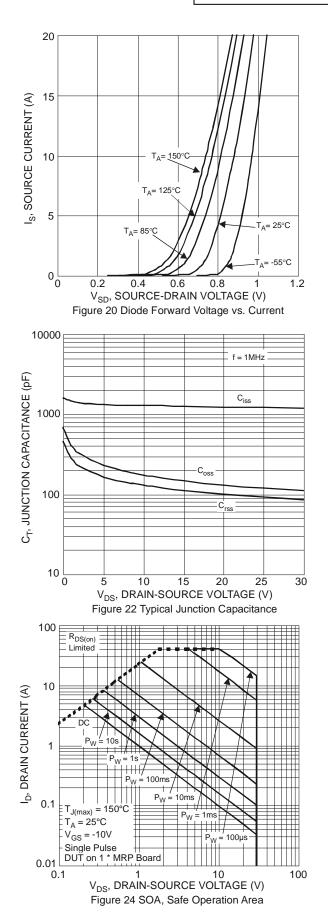
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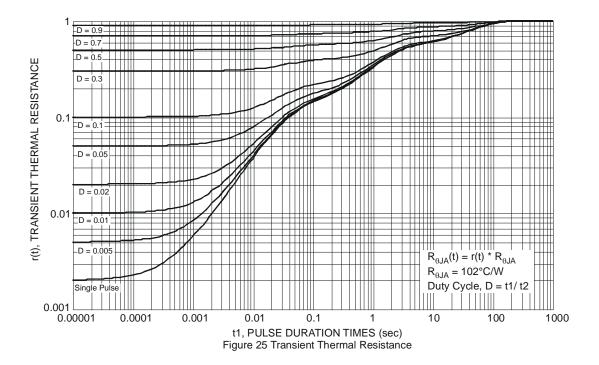


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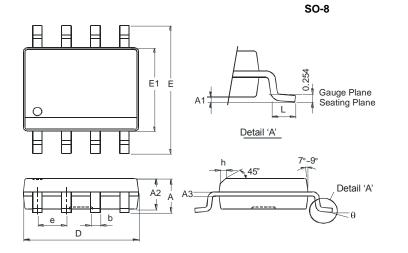






## **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

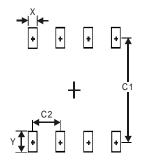


SO-8					
Dim	Min	Max			
Α	_	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
A3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	_	0.35			
L	0.62	0.82			
θ	0°	8°			
All Dimensions in mm					

### **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

SO-8



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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